2-Propanol CMOS

(iso-propyl alcohol)



Material No.: 9079-05 Batch No.: 0000192994

Manufactured Date: 2018/01/08 Retest Date: 2023/01/07

Revision No: 1

Certificate of Analysis

Test	Specification	Result
Assay (CH ₃ CHOHCH ₃)	>= 99.5 %	100.0
Color (APHA)	<= 10	5
Residue after Evaporation	<= 4 ppm	< 4
Solubility in H ₂ O	Passes Test	PT
Water (H2O)(by Karl Fischer titrn)	<= 0.05 %	0.01
Acidity (µeq/g)	<= 0.2	0.2
Alkalinity (µeq/g)	<= 0.1	< 0.1
Chloride (CI)	<= 0.1 ppm	< 0.1
Phosphate (PO ₄)	<= 0.3 ppm	0.1
Trace Impurities - Aluminum (Al)	<= 50.0 ppb	< 5.0
Arsenic and Antimony (as As)	<= 10 ppb	< 10
Trace Impurities - Barium (Ba)	<= 20.0 ppb	< 1.0
Trace Impurities - Beryllium (Be)	<= 100.0 ppb	< 1.0
Trace Impurities - Bismuth (Bi)	<= 100.0 ppb	< 10.0
Trace Impurities - Boron (B)	<= 10.0 ppb	< 5.0
Trace Impurities - Cadmium (Cd)	<= 20.0 ppb	< 1.0
Trace Impurities - Calcium (Ca)	<= 50.0 ppb	< 1.0
Trace Impurities - Chromium (Cr)	<= 20.0 ppb	< 1.0
Trace Impurities - Cobalt (Co)	<= 20.0 ppb	< 1.0
Trace Impurities - Copper (Cu)	<= 10.0 ppb	< 1.0
Trace Impurities – Gallium (Ga)	<= 50.0 ppb	< 1.0
Trace Impurities - Germanium (Ge)	<= 50.0 ppb	< 10.0
Trace Impurities - Gold (Au)	<= 20.0 ppb	< 5.0
Heavy Metals (as Pb)	<= 200 ppb	< 200

Material No.: 9079-05 Batch No.: 0000192994

Test	Specification	Result
Trace Impurities – Iron (Fe)	<= 50.0 ppb	< 1.0
Trace Impurities – Lead (Pb)	<= 20.0 ppb	< 10.0
Trace Impurities – Lithium (Li)	<= 50.0 ppb	< 1.0
Trace Impurities – Magnesium (Mg)	<= 20.0 ppb	< 1.0
Trace Impurities – Manganese (Mn)	<= 15.0 ppb	< 1.0
Frace Impurities – Molybdenum (Mo)	<= 100.0 ppb	< 5.0
Frace Impurities – Nickel (Ni)	<= 10.0 ppb	< 5.0
Trace Impurities – Niobium (Nb)	<= 100.0 ppb	< 1.0
Frace Impurities – Potassium (K)	<= 100.0 ppb	< 10.0
Frace Impurities – Silicon (Si)	<= 50.0 ppb	< 10.0
race Impurities – Silver (Ag)	<= 20.0 ppb	< 1.0
Frace Impurities – Sodium (Na)	<= 100.0 ppb	< 5.0
race Impurities – Strontium (Sr)	<= 20.0 ppb	< 1.0
Frace Impurities – Tantalum (Ta)	<= 100.0 ppb	< 5.0
Trace Impurities - Thallium (Tl)	<= 10.0 ppb	< 1.0
Frace Impurities – Tin (Sn)	<= 100.0 ppb	< 10.0
Frace Impurities – Titanium (Ti)	<= 20.0 ppb	< 1.0
Frace Impurities – Vanadium (V)	<= 100.0 ppb	< 1.0
Frace Impurities – Zinc (Zn)	<= 50.0 ppb	< 1.0
Trace Impurities – Zirconium (Zr)	<= 100.0 ppb	< 1.0
Particle Count – 0.2 µm and greater	<= 5000 par/ml	291
Particle Count – 0.3 µm and greater	<= 5000 par/ml	348
Particle Count – 0.5 µm and greater	<= 50 par/ml	6
Particle Count – 1.0 µm and greater	<= 8 par/ml	< 1

For Microelectronic Use

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000
Paris, KY 9001:2008
Mexico City, Mexico 9001:2008
Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003
Gliwice, Poland 9001:2008, 13485:2012
Selangor, Malaysia 9001:2008
Dehradun, India, 9001:2008, 14001:2004, 13485:2003
Mumbai, India, 9001:2008
Panoli, India 9001:2008

Jamie Ethier
Vice President Global Quality

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.573.2600 Avantor Performance Materials, LLC.